

Product/Process Change Notice - PCN 19_0115 Rev. -

Analog Devices, Inc. Three Technology Way Norwood, Massachusetts 02062-9106

This notice is to inform you of a change that will be made to certain ADI products (see Appendix A) that you may have purchased in the last 2 years. Any inquiries or requests with this PCN (additional data or samples) must be sent to ADI within 30 days of publication date. ADI contact information is listed below.

PCN Title: Notification of Additional Assembly Location, ASE Korea for LTM4630 and LTM4630A

Publication Date: 25-Jul-2019

Effectivity Date: 27-Oct-2019 (the earliest date that a customer could expect to receive changed material)

Revision Description:

Initial Release.

Description Of Change:

ADI is adding ASE Korea as an alternate assembly facility for LTM4630 and LTM4630A.

Reason For Change:

To qualify ASE Korea as an alternate assembly site to ensure the continuous availability of a reliable source of product supply.

Impact of the change (positive or negative) on fit, form, function & reliability:

This change will not impact fit, form, function and reliability.

Product Identification (this section will describe how to identify the changed material)

The approximate date code of the first units assembled by ASE Korea will be 1905.

Summary of Supporting Information:

Qualification has been performed per Industry Standard Test Methods (Qualification Result attached. ASE Korea is ISO9002, QS9000, ISO14001, TS16949, OHSAS 18001 and QC80000 certified. A summary of ASE Korea's product mix and ADI's qualification results are attached. The facility has passed a site audit by ADI's supplier quality organization. ADI product assembled in ASE Korea can be identified by the country of origin marked on the device as "KR". The product was qualified by performing extensive characterization over the full operating voltage and temperature ranges and MSL3 preconditioning. Devices from the same µModule device product family have been subjected to 1000 cycles of temperature cycles and thermal shock. Analog Devices performs reliability testing on production lots in accordance with our Quick Reaction Reliability (QR2) Monitor Program. This monitor program is designed to provide fast feedback for possible reliability problems associated with package assembly.

Supporting Documents

Attachment 1: Type: Qualification Results Summary

ADI_PCN_19_0115_Rev_-_rLTM4630 ASEK 2nd Source rel data.pdf

Attachment 2: Type: Other

ADI_PCN_19_0115_Rev_-_AEK-Capacity Summary.pdf

For questions on this PCN, please send an email to the regional contacts below or contact your local ADI sales representatives.

Americas: Europe: Japan: Rest of Asia:

PCN_Americas@analog.com PCN_Europe@analog.com PCN_Japan@analog.com PCN_ROA@analog.com

Appendix A - Affected ADI Models					
Added Parts On This Revision - Product Family / Model Number (19)					
LTM4630 / LTM4630EV#2LVPBF	LTM4630 / LTM4630EV#PBF	LTM4630/LTM4630EV#PBF-ES	LTM4630 / LTM4630EY#PBF	LTM4630 / LTM4630IV#2LVPBF	
LTM4630 / LTM4630IV#PBF	LTM4630 / LTM4630IY	LTM4630 / LTM4630IY#2LWPBF	LTM4630 / LTM4630IY#PBF	LTM4630-1 / LTM4630EY-1A#PBF	
LTM4630-1 / LTM4630EY-1B#PBF	LTM4630-1 / LTM4630IY-1A	LTM4630-1 / LTM4630IY-1A#PBF	LTM4630-1 / LTM4630IY-1B	LTM4630-1 / LTM4630IY-1B#PBF	
LTM4630A / LTM4630AEV#PBF	LTM4630A/LTM4630AEY#PBF	LTM4630A / LTM4630AIV#PBF	LTM4630A/LTM4630AIY#PBF		

Appendix B - Revision History				
Rev	Publish Date	Effectivity Date	Rev Description	
Rev	25-Jul-2019	27-Oct-2019	Initial Release.	

Analog Devices, Inc.

Docld:6730 Parent Docld:4640 Layout Rev:7